


<b>Search Notes</b> 	<b>Application/Control No.</b> 10540628	<b>Applicant(s)/Patent Under Reexamination</b> YOKOI ET AL.
	<b>Examiner</b> Deborah Yee	<b>Art Unit</b> 1793

SEARCHED			
Class	Subclass	Date	Examiner
148	330-336, 320	2/7/08	/DY/
420	105, 110	2/7/08	/DY/

SEARCH NOTES		
Search Notes	Date	Examiner

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner